

Title (en)
SYSTEM AND METHOD OF CLEANING AND ETCHING A SUBSTRATE

Title (de)
SYSTEM UND VERFAHREN ZUM REINIGEN UND ÄTZEN EINES SUBSTRATS

Title (fr)
SYSTEME ET PROCEDE DE NETTOYAGE ET DE GRAVURE D'UN SUBSTRAT

Publication
EP 1782461 A4 20080528 (EN)

Application
EP 05762857 A 20050623

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Abstract (en)
[origin: WO2006012174A2] One embodiment provides a method of processing a substrate. The method includes applying a solution to a surface of a substrate. At least one reacting species has been produced by dissociation of the solution by applying energy such as a light to the solution. A first material on the substrate is reacted and removing the reacted first material. A system for processing a substrate is also described.

IPC 8 full level
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CPC (source: EP KR)
H01L 21/304 (2013.01 - KR); **H01L 21/31133** (2013.01 - EP); **H01L 21/461** (2013.01 - KR); **H01L 21/6708** (2013.01 - EP)

Citation (search report)
• [X] US 6533902 B1 20030318 - MIKI NOBUHIRO [JP], et al & SILICON CARBIDE 2002 - MATERIALS, PROCESSING AND DEVICES. SYMPOSIUM 2-4 DEC. 2002 BOSTON, MA, USA, 2003, Silicon Carbide 2002 - Materials, Processing and Devices. Symposium (Mater. Res. Soc. Symposium Proceedings Vol.742) Mater. Res. Soc Warrendale, PA, USA, pages 271 - 276
• [X] DATABASE INSPEC [online] THE INSTITUTION OF ELECTRICAL ENGINEERS, STEVENAGE, GB; 2003, SASAKI D ET AL: "Photo-chemical pattern etching of silicon-carbide by using excimer laser and hydrogen peroxide solution", XP002476854, Database accession no. 7839009
• See references of WO 2006012174A2

Designated contracting state (EPC)
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